

TS321 低功耗单路运算放大器

1 特性

- 宽电源范围
 - 3V 至 30V 的单电源供电范围
 - $\pm 1.5\text{ V}$ 至 $\pm 15\text{ V}$ 的双电源供电范围
- 从 0V 至 3.5V（最低值）($V_{CC} = 5\text{ V}$) 的大输出电压摆幅
- 低电源电流：500 μA （典型值）
- 低输入偏置电流：20nA（典型值）
- 与高容式负载一起工作时保持稳定

2 应用

- 台式计算机
- HVAC：采暖、通风和空调
- 便携式媒体播放器
- 冰箱
- 洗衣机：高端和低端

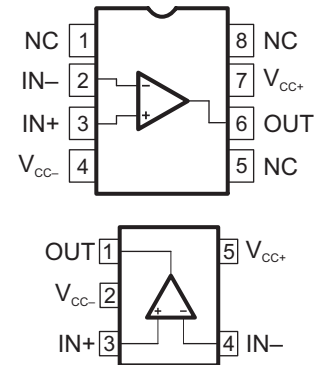
3 说明

TS321 是一种双极运算放大器，适用于注重节省空间的成本敏感型应用。

器件信息(1)

器件型号	封装	封装尺寸（标称值）
TS321	SOIC (8)	4.90mm × 3.90mm
	SOT-23 (5)	2.90mm × 1.60mm

(1) 如需了解所有可用封装，请参阅数据表末尾的可订购产品附录。



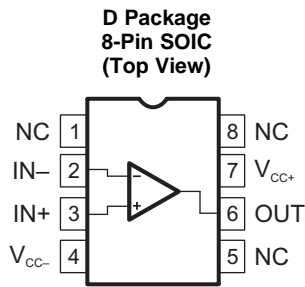
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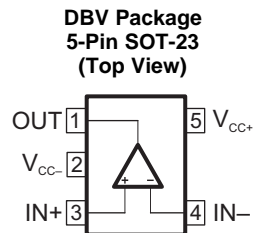
4 修订历史记录

Changes from Revision C (April 2015) to Revision D	Page
• 在器件信息 表中将 SOIC 封装引脚数量从“SOIC (14)”更正为“SOIC (8)”	1
Changes from Revision B (December 2013) to Revision C	Page
• 已添加 引脚配置和功能 部分、ESD 额定值 表、特性 说明 部分、器件功能模式、应用和实施 部分、电源相关建议 部分、布局 部分、器件和文档支持 部分以及机械、封装和可订购信息 部分	1

5 Pin Configuration and Functions



NC - no internal connection



Pin Functions

PIN			I/O	DESCRIPTION
NAME	SOIC	SOT-23		
IN-	2	4	I	Negative input
IN+	3	3	I	Positive input
NC	1	—	—	Do not connect
	5			
	8			
OUT	6	1	O	Output
V _{CC-}	4	2	—	Negative supply
V _{CC+}	7	5	—	Positive supply

6 Specifications

6.1 Absolute Maximum Ratings

 over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
Supply voltage, V_{CC}	Single supply		32	V
	Dual supplies		±16	
Differential input voltage ⁽²⁾ , V_{ID}			±32	V
Input voltage range ⁽³⁾ , V_I		–0.3	32	V
Input current, I_{IK}			50	mA
Duration of output short circuit to ground, t_{short}			Unlimited	
Operating virtual junction temperature, T_J			150	°C
Storage temperature, T_{stg}		–65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) Differential voltages are at IN+ with respect to IN–.
- (3) Input voltages are at IN with respect to V_{CC-} .

6.2 ESD Ratings

		VALUE	UNIT
$V_{(ESD)}$ Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2500	V
	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±1500	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

		MIN	MAX	UNIT
V_{CC} Supply voltage	Single supply	3	30	V
	Dual supply	±1.5	±15	
T_A	Operating free-air temperature	–40	125	°C

6.4 Thermal Information: TS321

THERMAL METRIC ⁽¹⁾ ⁽²⁾ ⁽³⁾	TS321		UNIT
	D (SOIC)	DBV (SOT-23)	
	5 PINS	5 PINS	
$R_{\theta JA}$ Junction-to-ambient thermal resistance	97	206	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.
- (2) Maximum power dissipation is a function of $T_J(max)$, q_{JA} , and T_A . The maximum allowable power dissipation at any allowable ambient temperature is $PD = [T_J(max) - T_A] / q_{JA}$. Selecting the maximum of 150°C can effect reliability.
- (3) The package thermal impedance is calculated in accordance with JESD 51-7.

6.5 Electrical Characteristics

 $V_{CC+} = 5\text{ V}$, $V_{CC-} = \text{GND}$, $V_O = 1.4\text{ V}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
V_{IO}	Input offset voltage	$R_S = 0$, $5\text{ V} < V_{CC+} < 30\text{ V}$ $0 < V_{IC} < (V_{CC+} - 1.5\text{ V})$	$T_A = 25^\circ\text{C}$		0.5	4	mV
			$T_A = \text{Full range}$			5	
I_{IO}	Input offset current	$T_A = 25^\circ\text{C}$			2	30	nA
		$T_A = \text{Full range}$				50	
I_{IB}	Input bias current ⁽¹⁾	$T_A = 25^\circ\text{C}$			20	150	nA
		$T_A = \text{Full range}$				200	
A_{VD}	Large-signal differential voltage amplification	$V_{CC} = 15\text{ V}$, $R_L = 2\text{ k}\Omega$ $V_O = 1.4\text{ V}$ to 11.4 V	$T_A = 25^\circ\text{C}$	50	100		V/mV
			$T_A = \text{Full range}$	25			
V_{ICR}	Common-mode input voltage ⁽²⁾	$V_{CC} = 30\text{ V}$	$T_A = 25^\circ\text{C}$	0	$V_{CC+} - 1.5$		V
			$T_A = \text{Full range}$	0	$V_{CC+} - 2$		
V_{OH}	High-level output voltage	$V_{CC} = 30\text{ V}$ $R_L = 2\text{ k}\Omega$	$T_A = 25^\circ\text{C}$	26	27		V
			$T_A = \text{Full range}$	25.5			
		$V_{CC} = 30\text{ V}$ $R_L = 10\text{ k}\Omega$	$T_A = 25^\circ\text{C}$	27	28		
			$T_A = \text{Full range}$	26.5			
V_{OL}	Low-level output voltage	$R_L = 10\text{ k}\Omega$	$T_A = 25^\circ\text{C}$		5	15	mV
			$T_A = \text{Full range}$			20	
GBP	Gain bandwidth product	$V_{CC} = 30\text{ V}$, $V_I = 10\text{ mV}$, $R_L = 2\text{ k}\Omega$ $f = 100\text{ kHz}$, $C_L = 100\text{ pF}$ $T_A = 25^\circ\text{C}$			0.8		MHz
SR	Slew rate	$V_{CC} = 15\text{ V}$, $V_I = 0.5\text{ V}$ to 3 V , $R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$, unity gain, $T_A = 25^\circ\text{C}$			0.4		V/ μs
ϕ_m	Phase margin	$T_A = 25^\circ\text{C}$			60		°
CMRR	Common-mode rejection ratio	$R_S \leq 10\text{ k}\Omega$ $T_A = 25^\circ\text{C}$		65	85		dB
I_{SOURCE}	Output source current	$V_{CC} = 15\text{ V}$, $V_O = 2\text{ V}$, $V_{ID} = 1\text{ V}$ $T_A = 25^\circ\text{C}$		20	40		mA
I_{SINK}	Output sink current	$V_{CC} = 15\text{ V}$, $V_{ID} = 1\text{ V}$ $V_O = 2\text{ V}$ $T_A = 25^\circ\text{C}$		10	20		mA
		$V_{CC} = 15\text{ V}$, $V_{ID} = 1\text{ V}$ $V_O = 0.2\text{ V}$ $T_A = 25^\circ\text{C}$		12	50		μA
I_O	Short-circuit to GND	$V_{CC} = 15\text{ V}$, $T_A = 25^\circ\text{C}$			40	60	mA
SVR	Supply-voltage rejection ratio	$V_{CC} = 5\text{ V}$ to 30 V , $T_A = 25^\circ\text{C}$		65	110		dB
I_{CC}	Total supply current	$V_{CC} = 5\text{ V}$ $T_A = 25^\circ\text{C}$, no load			500	800	μA
		$V_{CC} = 30\text{ V}$ $T_A = 25^\circ\text{C}$, no load			600	900	
		$V_{CC} = 5\text{ V}$ $T_A = \text{full range}$, no load			600	900	
		$V_{CC} = 30\text{ V}$ $T_A = \text{full range}$, no load				1000	
THD	Total harmonic distortion	$V_{CC} = 30\text{ V}$, $V_O = 2\text{ V}_{pp}$, $A_V = 20\text{ dB}$ $R_L = 2\text{ k}$, $f = 1\text{ kHz}$, $C_L = 100\text{ pF}$, $T_A = 25^\circ\text{C}$			0.015%		

(1) The direction of the input current is out of the device. This current essentially is constant, independent of the state of the output, so no loading change exists on the input lines.

(2) The input common-mode voltage of either input signal should not be allowed to go negative by more than 0.3 V. The upper end of the common-mode voltage range is $V_{CC+} - 1.5\text{ V}$, but either or both inputs can go to 32 V without damage.

Electrical Characteristics (continued)
 $V_{CC+} = 5\text{ V}$, $V_{CC-} = \text{GND}$, $V_O = 1.4\text{ V}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
e_N	Equivalent input noise voltage	$V_{CC} = 30\text{ V}$, $f = 1\text{ kHz}$, $R_S = 100\ \Omega$ $T_A = 25^\circ\text{C}$		50		

6.6 Typical Characteristics

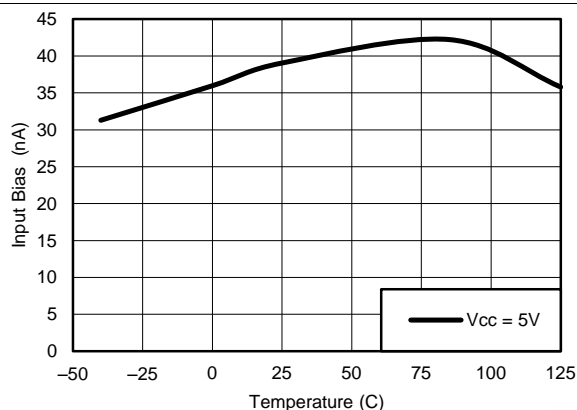


图 1. Input Current vs Temperature

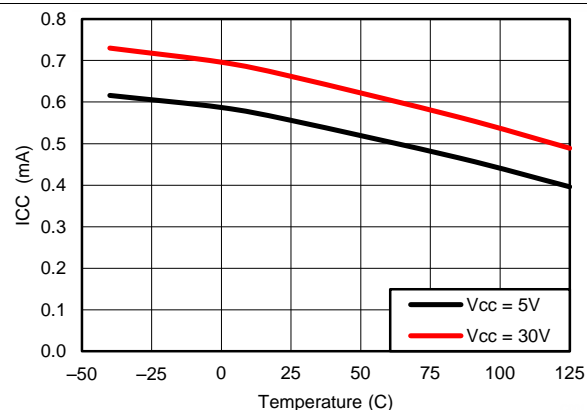


图 2. Supply Current vs Temperature

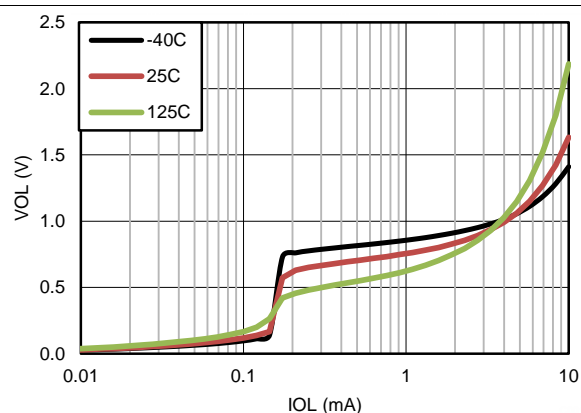


图 3. Output Sinking Characteristics

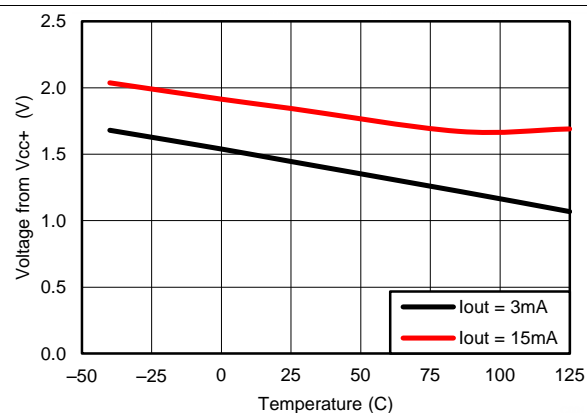


图 4. Output Sourcing Characteristics

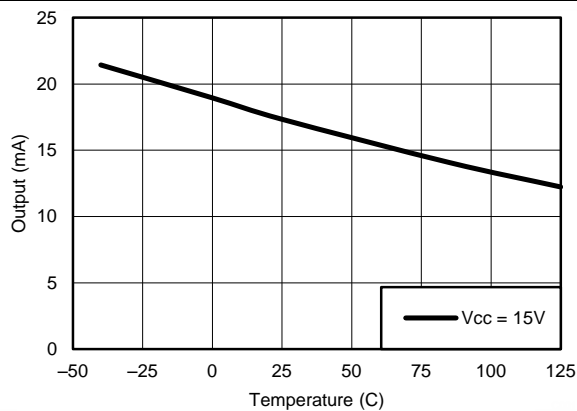


图 5. Short-Circuit Current to Supply ⁽¹⁾

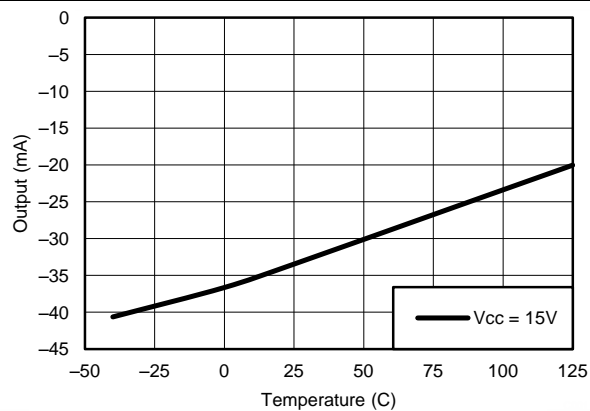


图 6. Short-Circuit Current to Ground

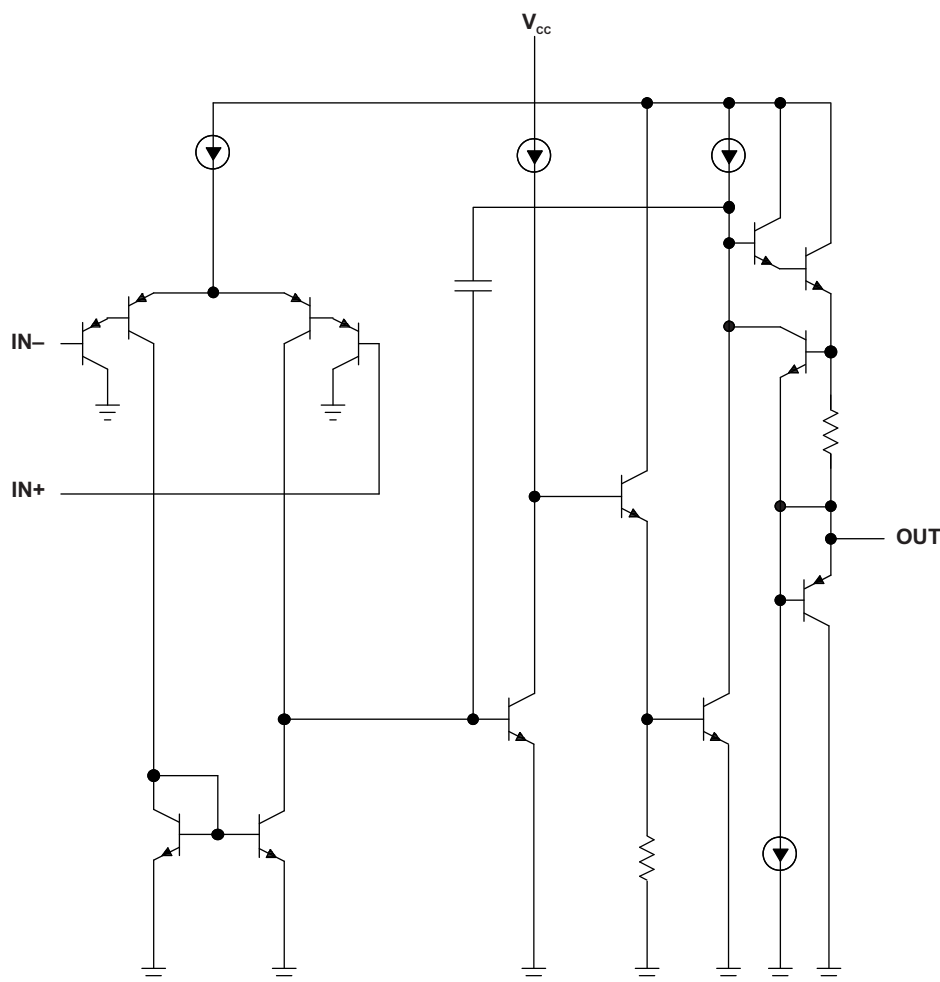
(1) Short circuits from outputs to VCC can cause excessive heating and eventual destruction.

7 Detailed Description

7.1 Overview

The TS321 is a single-channel operational amplifier. The device can handle a single supply between 3 V and 30 V or a dual-supply between ± 1.5 V and ± 15 V. Available in the small SOT-23 package, the TS321 is great for saving space in any application.

7.2 Functional Block Diagram



7.3 Feature Description

7.3.1 Operating Voltage

The TS321 can be powered from a single supply between 3 V and 30 V or a dual-supply between ± 1.5 V and ± 15 V.

7.3.2 Gain Bandwidth Product

Gain bandwidth product is found by multiplying a measured bandwidth of the amplifier by the gain at which that bandwidth was measured. The TS321 has a gain bandwidth of 0.8 MHz.

7.3.3 Slew Rate

The slew rate is the rate at which an operational amplifier can change the output when there is a change on the input. The TS321 has a 0.4-V/ μ s slew rate.

Feature Description (接下页)

7.3.4 Input Common-Mode Range

The valid common-mode range is from device ground pin to $V_{CC} - 1.5\text{ V}$ ($V_{CC} - 2\text{ V}$ across temperature). Inputs may exceed V_{CC} up to the maximum V_{CC} without device damage. At least one input must be in the valid input common-mode range for output to be correct phase. If both inputs exceed valid range then output phase is undefined. If either input is less than -0.3 V then input current must be limited to 1 mA and output phase is undefined.

7.3.5 Stability With High Capacitive Loads

Operational amplifiers have reduced phase margin when there is a direct capacitance on the output. The stability is affected most when the amplifier is set to unity gain. Small signal response to a step input of 100 mV reveals the loop stability with a range of capacitors. See [SLVA381](#) to correlate response waveform to phase margin. The responses at 1 nF or less indicate acceptable phase margin. The responses at $1\text{ }\mu\text{F}$ and above indicate good phase margin.

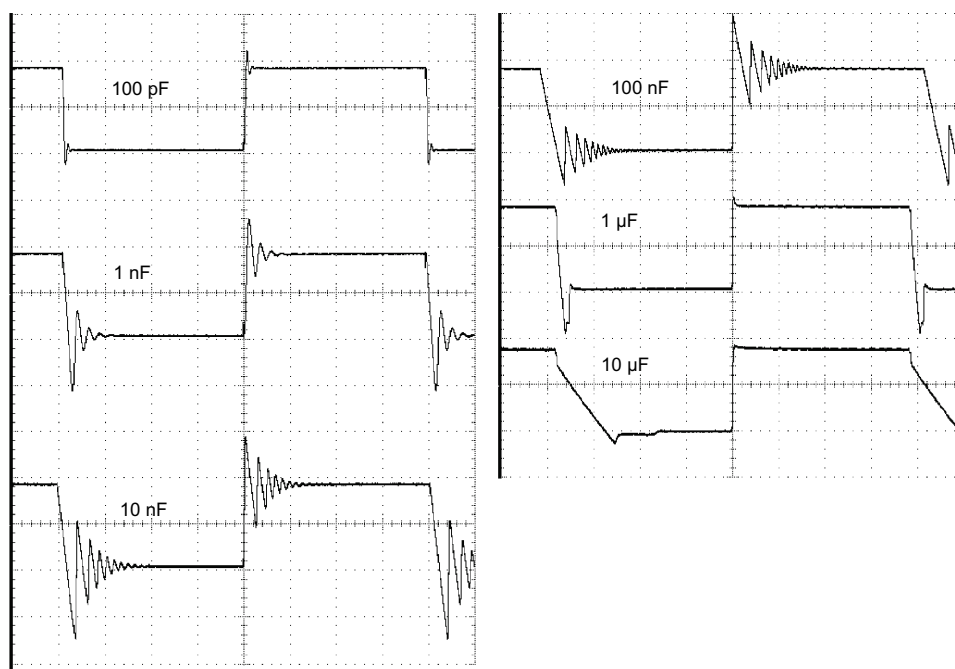


图 7. Small-Signal Response

7.4 Device Functional Modes

The TS321 is powered on when the supply is connected. This device can operate as a single-supply operational amplifier or dual-supply amplifier depending on the application.

8 Application and Implementation

注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

The TS321 operational amplifier is useful in a wide range of signal conditioning applications. Inputs can be powered before VCC for flexibility in multiple supply circuits.

8.2 Typical Application

A typical application for an operational amplifier in an inverting amplifier. This amplifier takes a positive voltage on the input, and makes the voltage a negative voltage of the same magnitude. In the same manner, the amplifier makes negative voltages positive.

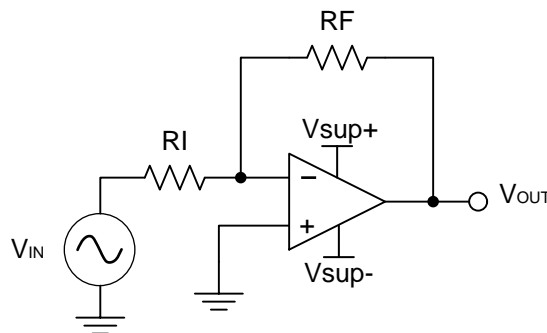


图 8. Typical Application Schematic

8.2.1 Design Requirements

The supply voltage must be selected such that the supply voltage is larger than the input voltage range and output range. For instance, this application scales a signal of ± 0.5 V to ± 1.8 V. Setting the supply at ± 12 V is sufficient to accommodate this application.

8.2.2 Detailed Design Procedure

Determine the gain required by the inverting amplifier:

$$A_V = \frac{V_{OUT}}{V_{IN}} \quad (1)$$

$$A_V = \frac{1.8}{-0.5} = -3.6 \quad (2)$$

Once the desired gain is determined, select a value for R_I or R_F . Selecting a value in the kilohm range is desirable because the amplifier circuit uses currents in the milliamp range. This ensures the part does not draw too much current. This example selects 10 k Ω for R_I which means 36 k Ω is to be used for R_F . This is determined by 公式 3.

$$A_V = -\frac{R_F}{R_I} \quad (3)$$

Typical Application (接下页)

8.2.3 Application Curve

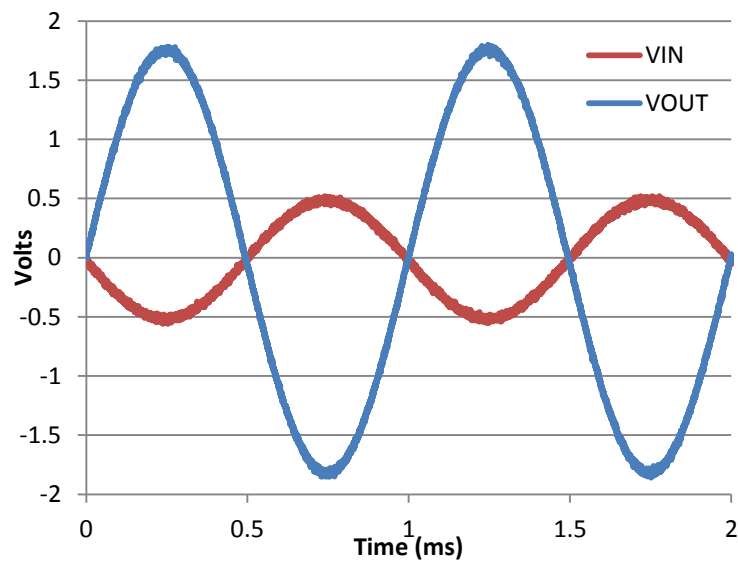


图 9. Input and Output Voltages of the Inverting Amplifier

9 Power Supply Recommendations

The TS321 is specified to operate between 3 V and 30 V or a dual supply between ± 1.5 V and ± 15 V.

CAUTION

Supply voltages larger than 32 V for a single supply, or outside the range of ± 16 V for a dual supply can permanently damage the device (see the [Absolute Maximum Ratings](#)).

Place 0.1- μ F bypass capacitors close to the power-supply pins to reduce errors coupling in from noisy or high impedance power supplies. For more detailed information on bypass capacitor placement, see the [Layout](#) section.

10 Layout

10.1 Layout Guidelines

For best operational performance of the device, use good PCB layout practices, including:

- Noise can propagate into analog circuitry through the power pins of the circuit as a whole, as well as the operational amplifier. Bypass capacitors are used to reduce the coupled noise by providing low impedance power sources local to the analog circuitry.
 - Connect low-ESR, 0.1- μ F ceramic bypass capacitors between each supply pin and ground, placed as close to the device as possible. A single bypass capacitor from V+ to ground is applicable for single supply applications.
- Separate grounding for analog and digital portions of circuitry is one of the simplest and most-effective methods of noise suppression. One or more layers on multilayer PCBs are usually devoted to ground planes. A ground plane helps distribute heat and reduces EMI noise pickup. Make sure to physically separate digital and analog grounds, paying attention to the flow of the ground current. For more detailed information, see [SLOA089](#).
- To reduce parasitic coupling, run the input traces as far away from the supply or output traces as possible. If it is not possible to keep them separate, it is much better to cross the sensitive trace perpendicular as opposed to in parallel with the noisy trace.
- Place the external components as close to the device as possible. Keeping RF and RG close to the inverting input minimizes parasitic capacitance, as shown in [Layout Example](#).
- Keep the length of input traces as short as possible. Always remember that the input traces are the most sensitive part of the circuit.
- Consider a driven, low-impedance guard ring around the critical traces. A guard ring can significantly reduce leakage currents from nearby traces that are at different potentials.

10.2 Layout Example

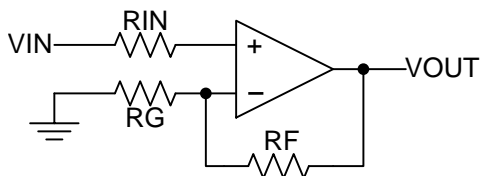


图 10. Operational Amplifier Schematic for Noninverting Configuration

Layout Example (接下页)

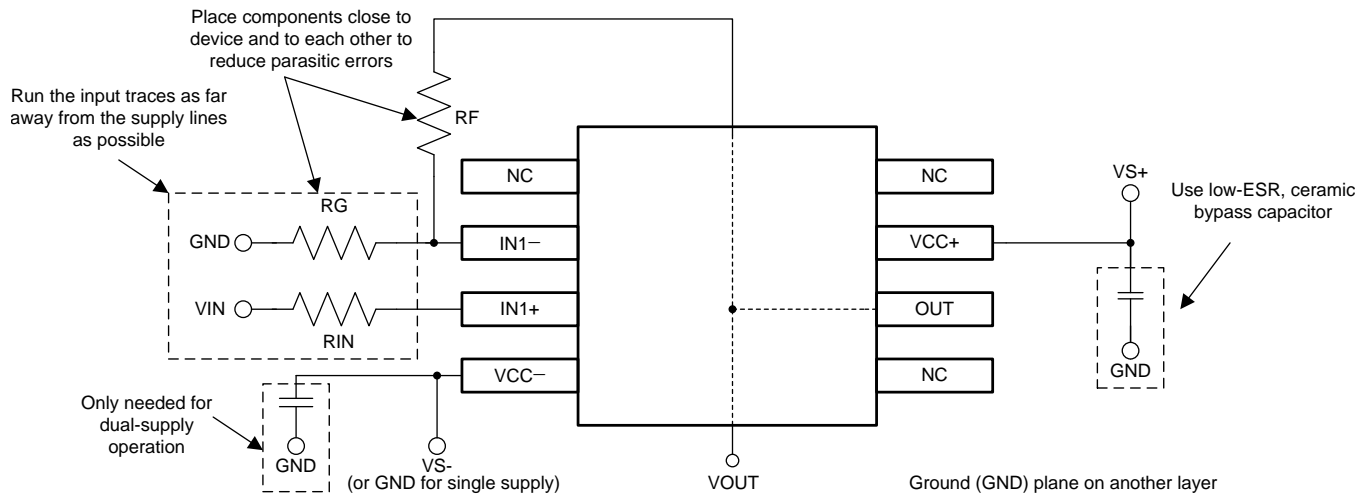


图 11. Operational Amplifier Board Layout for Noninverting Configuration

11 器件和文档支持

11.1 文档支持

11.1.1 相关文档

有关详细信息，请参阅以下内容：

- [简化稳定性检查](#)
- 《[电路板布局布线技巧](#)》

11.2 商标

All trademarks are the property of their respective owners.

11.3 静电放电警告



这些装置包含有限的内置 ESD 保护。存储或装卸时，应将导线一起截短或将装置放置于导电泡棉中，以防止 MOS 门极遭受静电损伤。

11.4 术语表

[SLYZ022](#) — TI 术语表。

这份术语表列出并解释术语、缩写和定义。

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TS321ID	Obsolete	Production	SOIC (D) 8	-	-	Call TI	Call TI	-40 to 125	SR321I
TS321IDBVR	Active	Production	SOT-23 (DBV) 5	3000 LARGE T&R	Yes	NIPDAU SN	Level-1-260C-UNLIM	-40 to 125	(9C1G, 9C1S)
TS321IDBVR.A	Active	Production	SOT-23 (DBV) 5	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	(9C1G, 9C1S)
TS321IDBVRG4	Obsolete	Production	SOT-23 (DBV) 5	-	-	Call TI	Call TI	-40 to 125	9C1G
TS321IDBVT	Active	Production	SOT-23 (DBV) 5	250 SMALL T&R	Yes	NIPDAU SN	Level-1-260C-UNLIM	-40 to 125	(9C1G, 9C1S)
TS321IDBVT.A	Active	Production	SOT-23 (DBV) 5	250 SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	(9C1G, 9C1S)
TS321IDR	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	SR321I
TS321IDR.A	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	SR321I

(1) **Status:** For more details on status, see our [product life cycle](#).

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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OTHER QUALIFIED VERSIONS OF TS321 :

- Automotive : [TS321-Q1](#)

NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TS321IDBVR	SOT-23	DBV	5	3000	178.0	9.0	3.23	3.17	1.37	4.0	8.0	Q3
TS321IDBVT	SOT-23	DBV	5	250	178.0	9.0	3.23	3.17	1.37	4.0	8.0	Q3
TS321IDBVT	SOT-23	DBV	5	250	180.0	8.4	3.23	3.17	1.37	4.0	8.0	Q3
TS321IDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TS321IDBVR	SOT-23	DBV	5	3000	180.0	180.0	18.0
TS321IDBVT	SOT-23	DBV	5	250	180.0	180.0	18.0
TS321IDBVT	SOT-23	DBV	5	250	202.0	201.0	28.0
TS321IDR	SOIC	D	8	2500	353.0	353.0	32.0



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NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Reference JEDEC MO-178.
4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25 mm per side.
5. Support pin may differ or may not be present.

EXAMPLE BOARD LAYOUT

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:15X



SOLDER MASK DETAILS

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NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:15X

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NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.



D0008A

PACKAGE OUTLINE

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



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NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MS-012, variation AA.

EXAMPLE BOARD LAYOUT

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:8X



SOLDER MASK DETAILS

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NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE
BASED ON .005 INCH [0.125 MM] THICK STENCIL
SCALE:8X

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NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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